

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/668,236	REBLEWSKI ET AL.
	<b>Examiner</b> Anh Q. Tran	<b>Art Unit</b> 2819

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
east search-see printout		2/22/2006	AT